Phasor XS™

Portable Phased Array Ultrasonic Flaw Detector



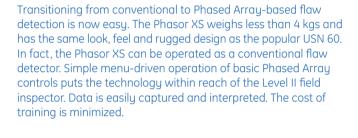
Combining the power of Phased Array with the comfort of conventional flaw detection at an accessible price.

The GE Phasor XS is your companion for improving everyday inspections.



Easy, portable and affordable

When used in Phased Array mode, the operator simply programs the transducer for multiple angles and focal depths without changing probes or wedges. Sector Scan with precise beam control results in improved probability of detection (POD) and sizing. With one scan from one contact location, greater area is covered and comprehensive data can be viewed in real-time on a full-color sector display. Compared to conventional ultrasonic inspection, the productivity and cost savings of the Phasor XS make it an easy decision for the NDT professional.



Sector Scan Capability

Sector Scan capability in the Phased Array mode significantly improves probability of detection while gaining productivity by scanning a larger volume in a single scan. Phasor XS supports up to 64 element physical probes and is capable firing up to 16 elements for beam forming. The easy to use on-board delay law calculator makes it simple and fast to program the tranducer.

Advanced Measurement Tools

Phasor XS supports a full complement of measurement tools. Two sets of cursors allow for signal sizing and true depth measurement while horizontal location measurement is also possible. User-friendly color schemes make measurement simple and quick.

User-friendly Interface

The Phasor XS features a 6.5" VGA display with a best-in-class 60 Hz data refresh rate and a choice of selectable screen options that allow optimum viewing even in the most difficult field conditions. Several options are available including unique views such as Video Reverse which allows users to align the sector view with the probe. Selectable A-Scans can also be viewed along with the Sector Scan.







Rapid Reporting

JPEG images, sector scans or other views can be stored with a single key press as part of the unique Freeze Mode and downloaded in image-ready format to an SD $^{\text{TM}}$ solid-state memory card for fast documentation or report generation.

Multiple Phased Array Transducer Options

GE Inspection Technologies manufactures a wide variety of Phased Array transducers that are applicable to Phasor XS.



Phased Array transducers with Dialog feature recognize physical connection and automatically download transducer information to Phasor XS.

A catalog of both conventional and Phased Array transducers is available at: www.ge.com/phasorxs

Feature Summary

- Ultra-portable Phased Array at less than 3.8 kg (8.2 lbs)
- Industry standard code-compliant flaw detector
- Electronically controlled and selectable beam angles, focus and size
- Simultaneous inspection with multiple beams from a single location
- Simple operation allows for easy transition from conventional UT to Phased Array inspection
- Field-proven rugged packaging to withstand heavy on-site use
- Full-color, real-time sector display with selectable A-Scan
- Full-screen display and snap-shot image storage of sector images, A-Scans, B-Scans, measurement and on-screen set-up parameters
- JPEG image reporting and data-set transfer via SD memory card
- On-board delay law calculator
- Push-button control for ease-of-use and operation within a sealed bag for anti-contamination

Product	Frequency	Elements							Cable	
code		Count	Aperture		Elevation		Pitch		Length	
	MHz		mm²	inch²	mm	inch	mm	inch		
L8U84	2	8	8 × 9	.31 x .35	9	.35	1	.039	2	6.5
L8U96	4	16	8 × 9	.31 × .35	9	.35	0.5	.020	2	6.5
EUN75	5	32	16 × 10	.63 x .39	10	.39	0.5	.020	2	6.5
L99HK	5	16	16 × 10	.63 x .39	10	.39	1	.039	2	6.5
L99KO	2.25	16	16 × 13	.63 x .51	13	.51	1	.039	2	6.5
L99LQ	2.25	16	24 × 19	.94 x .75	19	.75	1.5	.059	2	6.5
L99JM	5	64	64 × 10	2.5 x .39	10	.39	1	.039	2	6.5

Technical Specifications

Physical Specifications	
Internal Memory	Set-up files
Removable Memory	On 512 MB SD Card for report and set-up files
Documentation Format	JPEG ~80 KB/image
Weight	3.8 kg (8.2 lbs) with battery
Dimensions	282 mm W x 171 mm H x 159 mm D
	(11.1 in. W x 6.8 in. H x 6.3 in. D)
Battery	Custom Li Ion battery pack - 356P configuration
Battery Life	6 hrs minimum
Battery Charging	External charger
External Power Supply	Universal input 85 to 260 V AC / 50 to 60 Hz
Probe Connectors	Conventional - 00 lemo/BNC adapters provided -
	Phased Array - Custom ZIF
VGA Output	Yes
Dialog Languages	Chinese, English, French, German, Italian, Japanese, and Spanish
Display Size	165 mm (6.5 in.) diagonal
Display Resolution	VGA color TFT 640H x 480V pixel
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	Conventional	Phased Array	
Pulser	Spike	Bi-Polar Square Wave	
Pulse Repetition Frequency	15 to 2000 Hz	15 to 7680 Hz	
Pulser Voltage	300 V max	± 25 V to ± 75 V (1 V steps)	
Pulser Energy	Low or High (selectable)		
Pulser Rise Time	< 15 nsec	< 15 nsec	
Damping	50 or 1000 Ohms (selectable)		
Mode of operation	single, dual	single	
Receiver Input Capacitance	< 50 pF		
Receiver Input Resistence	1000 Ohms in dual mode	220 Ohms	
Maximum Input Voltage	40 V peak-to-peak	200 mV peak-to-peak	
Bandwidth/Amplifier BandPath	0.3 to 15 MHz @ -3dB	selectable	
requency Selection	1.0, 2.0, 2.25, 4.0, 5.0, 10 and 15 MHZ + BB	2.25, 4.0, and 5.0 MHZ + LP & HP	
Rectification	Pos HW, Neg HW, FW, and RF	Pos HW, Neg HW, FW and RF	
Analog Gain	0 to 110 dB	0 to 40 dB	
Digital Gain		0 to 53.9 dB	
Focal Laws		User selectable - 128 max	
Phusical Probe		1 to 64	
Virtual Probe		1 to 16	
Number of Cycles		1 to 128	
Pulser Width @ 1/2 Cycle		20 to 500 nsec	
Pulser Delau		0 to 10.24 u-sec	
Receiver Delau		0 to 10.24 µ-sec	
Acoustic Velocity	1000 to 16000 m/s	1000 to 16000 m/s	
toodsto velocity	0.0393 to 0.5905 in./µ-sec	0.0393 to 0.5905 in./µ-sec	
Minimum Range (steel long)	0 -14 mm (0.55 inch)	0 - 7.6 mm (0.3 inch)	
(steel shear)	0 - 7.5 mm (0.3 inch)	0 - 4.2 mm (0.17 inch)	
Maximum Range (steel long)	0 - 14060 mm (553 inch)	0 - 1073 mm (42 inch)	
(steel shear)	0 - 7626 mm (300 inch)	0 - 1073 mm (42 inch)	
Display Delay	2.5 m (98.5 inch)	1 m (39.4 inch)	
Auto Timebase Calibration	Yes	1 III (55.4 IIICII)	
Reject	0 to 80%	0 to 80%	
TCG	15 points @ 6 dB/µ-sec	15 points @ 6 dB/µ-sec	
Gates	A and B	A, B and IF	
Gate Threshold	5 to 95%	5 to 95%	
Gate Start	0 mm - full range	0 mm - full range	
Gate Width	1 mm - full range	1 mm - full range	
	Off, Positive, and Negative	Off, Positive, and Negative	
Gate Logic	(Off, Positive, and Negative (Off, Coincidence, and Anticoincidence)	(Off, Coincidence, and Anticoincidence)	
TOE Madas	Flank/Peak	Flank/Peak	
TOF Modes	FIUNK/PEUK	Linear and Sector	
Scan Type	A C		
Available Views	A-Scan	A-Scan, B-Scan and Sector	
Displayed Readings	Amplitude, Sound Path, and Trig	Beam, Amplitude, Sound Path,	
	Ē	Trig for displayed and for all beams	
Measurement Resolution	5 nsec	5 nsec	
Displayed Units of Measurements	mm or inch (selectable)	mm or inch (selectable)	

Environmental Tests					
Per Mil-Std-810F					
Cold Storage	-20°C for 72 hrs, 502.4 Procedure I				
Cold Operation	0°C for 16 hrs, 502.4 Procedure II				
Heat Storage	+70°C for 48 hrs, 501.4 Procedure I				
Heat Operation	+50°C for 16 hrs, 501.4 Procedure II				
Damp Heat / Humidity (storage)	10 Cycles: 10 hrs at +65°C down to +30°C, 10 hrs at +30°C up to +65°C, transitions within 2 hrs, 507.4				
Temperature Shock	3 Cycles: 4 hrs at -20°C up to +70°C, 4 hrs at +70°C, transitions within 5 mins. 503.4 Procedure II				
Vibration	514.5-5 Procedure I, Annex C, Figure 6, general exposure: 1 hr each axis				
Shock	6 cycles each axis, 15g, 11ms half sine, 516.5 Procedure I				
Loose Cargo	514.5 Procedure II				
Transit Drop (packaged for shipment)	516.5 Procedure IV, 26 drops				

Specifications subject to change without notice.

specifications for IP54 classification

All blank fields are non-applicable

www.ge.com/phasorxs



GE Inspection Technologies: productivity through inspection solutions

GE Inspection Technologies provides technology-driven inspection solutions that deliver productivity, quality and safety. We design, manufacture and service Ultrasonic, Remote Visual, Radiographic and Eddy Current equipment and systems. Offering specialized solutions that will help you improve productivity in your applications in the Aerospace, Power Generation, Oil & Gas, Automotive or Metals Industry. Contact your GE Inspection Technologies representative or visit www.ge.com/inspectiontechnologies for more information.